

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 13906-157001	Application No. 10/814,836
<b>Information Disclosure Statement by Applicant.</b> (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Wu et al.	
		Filing Date March 31, 2004	Group Art Unit 2114

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
/PFC/	AA	US2002/122050	5/9/2002	Jabe A. Sandberg			
	AB	2002/0083156	06/2002	Wysoczynski, Jacek Piotr			
	AC	4,654,852	03/1987	Bentley et al.			
	AD	5,748,880	5/1998	Ito et al.			
	AE	5,877,961	03/1999	Moore, William C			
	AF	5,917,898	06/1999	Bassa et al.			
	AG	5,944,839	08/1999	Ishenberg, Henri J.			
	AH	6,477,531	11/2002	Sullivan et al.			
	AI	6,539,499	03/2003	Stedman et al.			
	AJ	6,560,721	05/2003	Boardman et al.			
	AK	6,678,639	01/2004	Little et al.			
	AL	6,888,542	05/2005	Clauss, James M.			
	AM	6,990,602	01/2006	Skinner et al.			
	AN	2004/0078692	04/2004	Jackson et al.			
	AO	2003/0131290	07/2003	Weinberg et al.			
	AP	6,134,644	10/2000	Mayuzumi et al.			
	AQ	6,834,363	12/2004	Austen et al.			
	AR	6,078,189	06-2000	Noel, Leo A.			
	AS	5,708,774	01/1998	Boden, Edward Barnes			
	AT	2002/0116666	08/2002	Perez et al.			
	AU	6,557,115	04/2003	Gillenwater et al.			
	AV	6,233,701	5/2001	Onoue, Kunihito			
	AW	5,587,930	12/1996	Hori et al.			
	AX	5,414,836	05/1995	Baer et al.			
	AY	6,757,634	6/2004	Lara, John M.			
/PFC/	AZ	6,195,763	2/2001	Mayer et al.			

Foreign Patent Documents or Published Foreign Patent Applications	
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							Yes	No
/PFC/	AAA	WO0118652	03/2001	WIPO				
/PFC/	ABB	WO9715009	04/1997	WIPO				
	ACC							

Other Documents (Include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
/PFC/	ADD	Microsoft Press Computer Dictionary Third Edition, "error rate", Microsoft Press, 1997, pg. 180.
/PFC/	AEE	IBM Technical Disclosure Bulletin, Priority Based System Test Method, September 2001, IBM Corporation, Issue 449, Page 1566.
	AFF	
	AGG	

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	AK						

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	AL							
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	AN							
	AO							
	AP							

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	AS	
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